


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/075,264	CHIU ET AL.	
	Examiner	Art Unit	
	Brian Jelinek	2615	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS	SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
348	169			348	349				
INTERNATIONAL CLASSIFICATION				382	103	170			
H	0	4	N	5/225					
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<i>Brian Jelinek</i> 7/11/05 (Assistant Examiner) (Date)	<i>David L. Ometz</i> 7/19/05 DAVID L. OMETZ PRIMARY EXAMINER (Primary Examiner) (Date)	Total Claims Allowed: 10 <table> <tr> <td>O.G. Print Claim(s)</td> <td>O.G. Print Fig.</td> </tr> <tr> <td>1</td> <td>4</td> </tr> </table>	O.G. Print Claim(s)	O.G. Print Fig.	1	4
O.G. Print Claim(s)	O.G. Print Fig.					
1	4					

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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